

Notice of References Cited	Application/Control No. 09/890,266	Applicant(s)/Patent Under Reexamination OHNO ET AL.	
	Examiner MISOOK YU, Ph.D.	Art Unit 1642	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,861,159	01-1999	Pardoll et al.	424/184.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Entry of "microparticle in Meririam-Webster Online downloaded on 3/13/2005 from url>>www.m-w.com
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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